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| Form PTO 1449 (Rev. 2-32) | | | | | | U.S. Department of Commerce Patent and Trademark Office | | Atty. Docket No. 034299-674 | | Serial No. 10/560,973 | |
| Information Disclosure Statement by Applicant (Use several sheets if necessary) | | | | | | | | Applicant: Francois Perraut, et al. | | | |
| | | | | | | | | Filed: December 14, 2005 | | Group: (to be assigned) | |
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| Examiner | | | | | Date Considered | | | | | | |
| Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant. | | | | | | | | | | | |